

Notice of References Cited	Application/Control No. 10/772,422		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Shin-Hon Chen		Art Unit 2131	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,477,646	11-2002	Krishna et al.	713/189
*	B	US-2003/0225991	12-2003	Calderon et al.	711/173
*	C	US-2001/0019610	09-2001	Shimoyama, Takeshi	380/29
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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